TC74LCX273F/FW/FT

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74LCX273F,TC74LCX273FW,TC74LCX273FT

Low-Voltage Octal D-Type Flip-Flop with Clear with 5-V Tolerant Inputs and Outputs

The TC74LCX273F/FW/FT is a high-performance CMOS octal D-type flip-flop. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low-power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

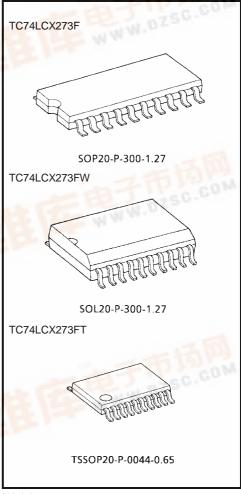
This 8 bit D-type flip-flop is controlled by a clock input (CK) and a clear input (CLR). When the CLR input is low, the eight outputs are at a low logic level.

All inputs are equipped with protection circuits against static discharge.

Features

- Low-voltage operation: $V_{CC} = 2.0$ to 3.6 V
- High-speed operation: $t_{pd} = 8.5 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$
- Output current: |IOH|/IOL = 24 mA (min) (VCC = 3.0 V)
- Latch-up performance: ±500 mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- Power-down protection is provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 273 type

Note: xxxFW (JEDEC SOP) is not available in Japan.

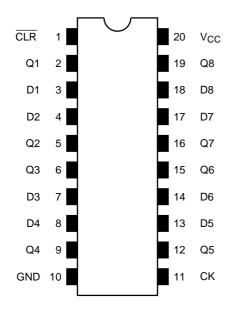


Weight

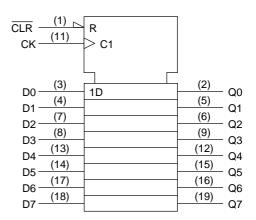
SOP20-P-300-1.27: 0.22 g (typ.) SOL20-P-300-1.27: 0.46 g (typ.) TSSOP20-P-0044-0.65: 0.08 g (typ.) WWW.DZSC.COM



Pin Assignment (top view)



IEC Logic Symbol

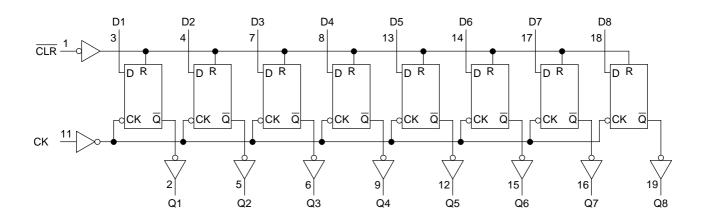


Truth Table

	Inputs		Outputs	Function
CLR	D	CK	Q	Tariction
L	Х	Х	L	Clear
Н	L		L	_
Н	Н		Н	_
Н	Х	7	Qn	No change

X: Don't care

System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit	
Power supply voltage	Vcc	-0.5 to 7.0	V	
DC input voltage	V _{IN}	-0.5 to 7.0	V	
		-0.5 to 7.0 (Note 1)		
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V	
		(Note 2)		
Input diode current	I _{IK}	-50	mA	
Output diode current	I _{OK}	±50 (Note 3)	mA	
DC output current	I _{OUT}	±50	mA	
Power dissipation	P _D	180	mW	
DC V _{CC} /ground current	I _{CC} /I _{GND}	±100	mA	
Storage temperature	T _{stg}	-65 to 150	°C	

Note 1: $V_{CC} = 0 V$

Note 2: High or low state. IOUT absolute maximum rating must be observed.

Note 3: Vout < GND, Vout > Vcc

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Power supply voltage	Vcc	2.0 to 3.6	V	
Power supply voltage	v CC	-1.5 to 3.6 (Note 4)	V	
Input voltage	V _{IN}	0 to 5.5	V	
Output voltage	Vout	0 to 5.5 (Note 5)	V	
Output voltage	VOU1	0 to V _{CC} (Note 6)	V	
Output current	I _{OH} /I _{OL}	±24 (Note 7)	mA	
Output current	IOH/IOL	±12 (Note 8)	ША	
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 9)	ns/V	

Note 4: Data retention only

Note 5: $V_{CC} = 0 V$

Note 6: High or low state

Note 7: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 8: $V_{CC} = 2.7 \text{ to } 3.0 \text{ V}$

Note 9: $V_{IN} = 0.8 \text{ to } 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$

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Electrical Characteristics

DC Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Characteristics		Symbol	Test Condition			Min	Max	Unit
		Symbol			V _{CC} (V)			Offic
Input voltage	H-level	V _{IH}				2.0	_	V
input voltage	L-level	V _{IL}				_	0.8	v
			I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	V _{OH}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OH} = -12 mA	2.7	2.2	_	V
				I _{OH} = -18 mA	3.0	2.4	_	
Output voltage L-level				I _{OH} = -24 mA	3.0	2.2	_	
		Va	V _{IN} = V _{IH} or V _{II}	I _{OL} = 100 μA	2.7 to 3.6	_	0.2	
	Llovol			I _{OL} = 12 mA	2.7	_	0.4	
	V _{OL}	VIN = VIH OI VIL	I _{OL} = 16 mA	3.0	_	0.4		
				I _{OL} = 24 mA	3.0	_	0.55	
Input leakage cur	rent	I _{IN}	V _{IN} = 0 to 5.5 V		2.7 to 3.6	_	±5.0	μА
Power-off leakage	e current	l _{OFF}	V _{IN} /V _{OUT} = 5.5 V		0	_	10.0	μА
Quiescent supply current		laa	V _{IN} = V _{CC} or GND		2.7 to 3.6	_	10.0	
		Icc	V _{IN} = 3.6 to 5.5 V	2.7 to 3.6	_	±10.0	μΑ	
Increase in Icc per input		Δlcc	$V_{IN} = V_{CC} - 0.6 V$	2.7 to 3.6	_	500		

AC Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Maximum clock fraguency	t.	(Figure 1, Figure 2)	2.7	_	_	MHz
Maximum clock frequency	f _{MAX}	(Figure 1, Figure 2)		150	_	IVIITZ
Propagation delay time (CK-Q)	t _{PLH}	(Figure 1, Figure 2)	2.7	_	9.5	ne
Propagation delay time (CR-Q)	t _{PHL}	(Figure 1, Figure 2)	3.3 ± 0.3	1.5	8.5	ns
Propagation delay time (CLR -Q)	t _{PHL}	(Figure 1, Figure 3)	2.7	_	9.5	ns
Tropagation delay time (CER -Q)	PHL	(i igure 1, i igure 3)	3.3 ± 0.3	1.5	8.5	
Minimum pulse width (CK)	t _{w (H)}	(Figure 1, Figure 2)	2.7	3.3		ns
Willim puise width (OR)	t _{w (L)}	(i igure 1, i igure 2)	3.3 ± 0.3	3.3		
Minimum pulse width (CLR)	t a.	(Figure 3)	2.7	3.3		ns
Minimum puise width (CER)	t _{w (L)}	(i igure 3)	3.3 ± 0.3	3.3		113
Minimum setup time	t _s	(Figure 1, Figure 2)	2.7	2.5		ns
iviiriiinum setap time	ÿ	(i igure 1, i igure 2)	3.3 ± 0.3	2.5		113
Minimum hold time	+ .	(Figure 1, Figure 2)	2.7	1.5	_	ns
	t _h	(Figure 1, Figure 2)	3.3 ± 0.3	1.5	_	115
Minimum removal time	t _{rem}	(Figure 4)	2.7	2.5	_	ns
		(Figure 4)	3.3 ± 0.3	2.0	_	115
Output to output allow	t _{osLH}	(Note 10)	2.7	_		ns
Output to output skew	t _{osHL}	(Note 10)	3.3 ± 0.3	_	1.0	113

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Note 10: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ Ω)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	V

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}			3.3	7	pF
Output capacitance	C _{OUT}	_		0	8	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note 11)	3.3	25	pF

Note 11: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$

AC Test Circuit

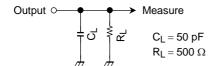


Figure 1

AC Waveform

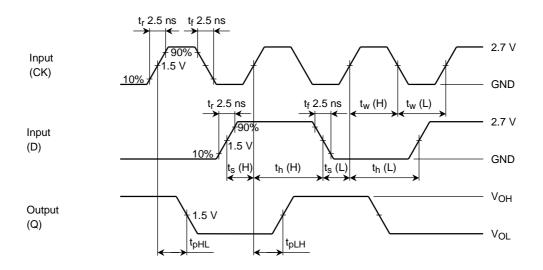


Figure 2 t_{pLH} , t_{pHL} , t_w , t_s , t_h

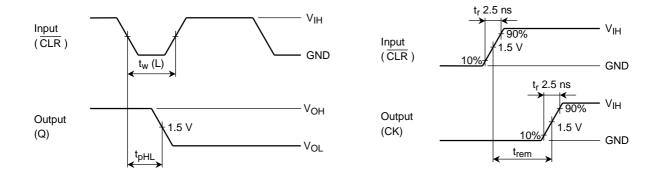
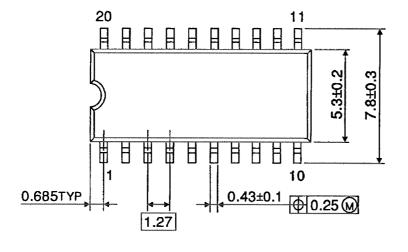


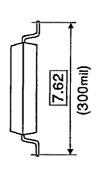
Figure 3 tpHL

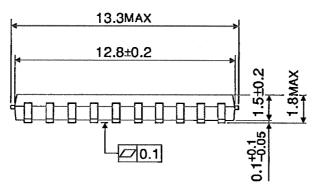
Figure 4 trem

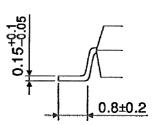
Package Dimensions

SOP20-P-300-1.27 Unit: mm







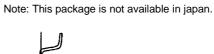


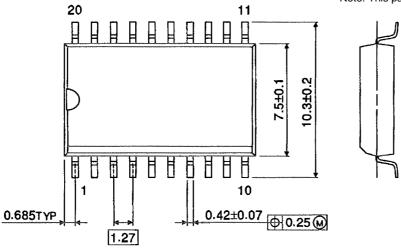
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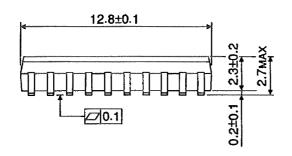
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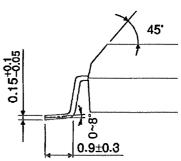
Package Dimensions

SOL20-P-300-1.27







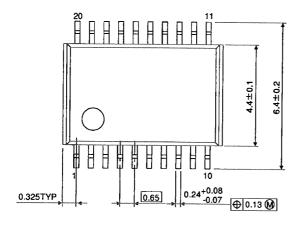


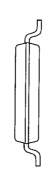
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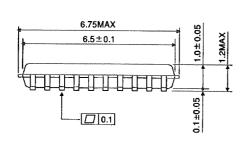
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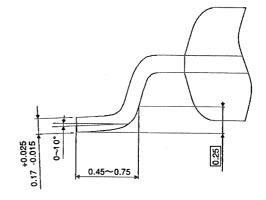
TSSOP20-P-0044-0.65

Unit: mm









Weight: 0.08 g (typ.)

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